ON Semiconductor



Title of Change:	Data Sheet Correction for NCP51200 / NCP51400 Family of Devices
Effective date:	3 May 2016
Contact information:	Contact your local ON Semiconductor Sales Office or <alan.garlington@onsemi.com></alan.garlington@onsemi.com>
Type of notification:	ON Semiconductor will consider this change accepted.
Change category:	Wafer Fab Change Assembly Change Test Change Other_Datasheet
Change Sub-Category(s):	
Sites Affected: All site(s) Image: Construction of the state of the	
Description and Purpose: There is no change to the parts or the testing of these parts as a result of this notification. This is a data sheet correction only. The Vcc UVLO Threshold minimum limit in the data sheet Electrical Characteristics table will be changed to match the value which is actually being tested. Vcc UVLO Threshold Wake Up, TA = +25C Previous Min Value = 2.2 V New Min Value = 2.15 V	
List of affected Standard Parts:	
NCP51200MNTWG	NCP51403MNTXG
NCP51200MNTXG	NCV51200MNTXG
NCP51400MNTXG	NCV51200MWTXG
NCP51401MNTXG	NCV51400MNTXG
NCP51402MNTXG	NCV51400MWTXG